

RICOH

R3130N/R3131N SERIES

Low Voltage Detector with Built-in Delay Circuit

NO.EA-073-160315

OUTLINE

R3130N/R3131N Series are CMOS-based low voltage detector ICs with built-in delay circuit, high Detector Threshold accuracy and ultra low supply current which can be operated at low voltage.

These ICs can be used as system reset generator, and each of these ICs consists of a voltage reference, a comparator, resistors for setting voltage detector threshold, an output driver transistor, and an output delay generator.

Detector threshold is fixed internally with high accuracy and requires no adjustment. When Supply Voltage crosses a setting detector threshold voltage from a high value to a lower value, this IC generates reset signal.

R3130N Series output "L" at detection mode, while R3131N Series output "H".

Further, each of R3130N/R3131N Series embeds an output delay generator, when Supply Voltage crosses a setting detector threshold voltage from a low value to a higher value, during a setting delay time which is fixed in the IC, this IC keeps the reset condition. Output Delay Time can be selected. (Typ. 240ms is standard.)

Two output types, Nch open drain type and CMOS type, are available.

Since the package for these ICs is SOT23-3 (Mini-mold) package, high density mounting of the ICs on board is possible.

FEATURES

- Pin to Pin compatible with MAX 809/810 (R3130Nxxxx: MAX 809, R3131Nxxxx: MAX 810)
- Ultra-low supply Current Typ. 1.25 μ A (R313xN27xx: V_{DD}=3.0V)
- Operating Voltage Range 1.0V to 6.0V (T_{opt}=25°C)
- Detector Threshold..... Setting with a step of 0.1V in the range of 1.6V to 4.8V is possible.
- Embedded Power on Reset Delay Time Circuit Delay Time can be designated.
Refer to Selection Guide.
- High Accuracy Detector Threshold $\pm 1.5\%$
- High Accuracy Output Delay Time $\pm 10.0\%$
- Low Temperature-Drift Coefficient of Detector Threshold... Typ. $\pm 100\text{ppm}/^\circ\text{C}$
- Two Output Types Nch Open Drain and CMOS
- Small Package SOT-23-3

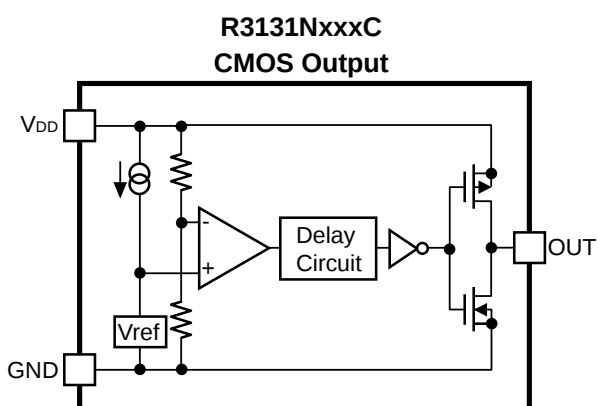
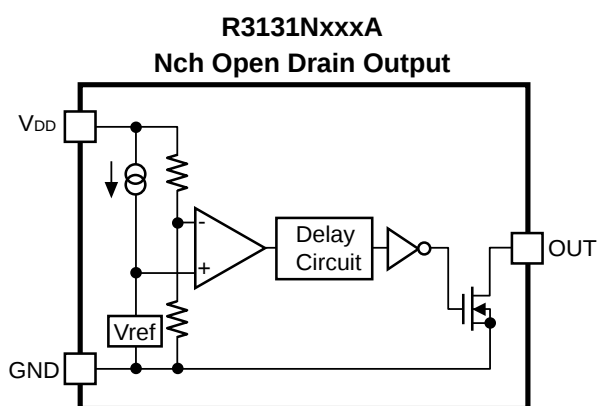
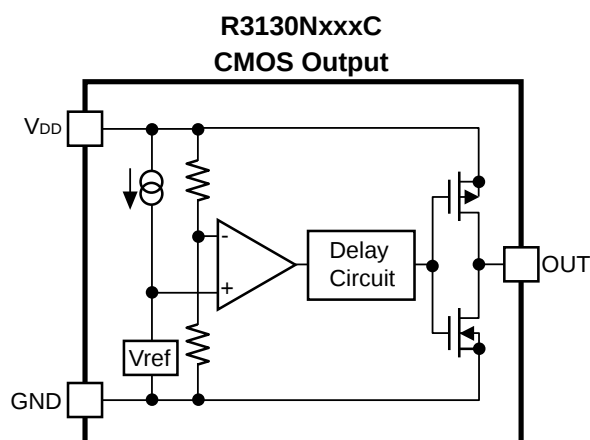
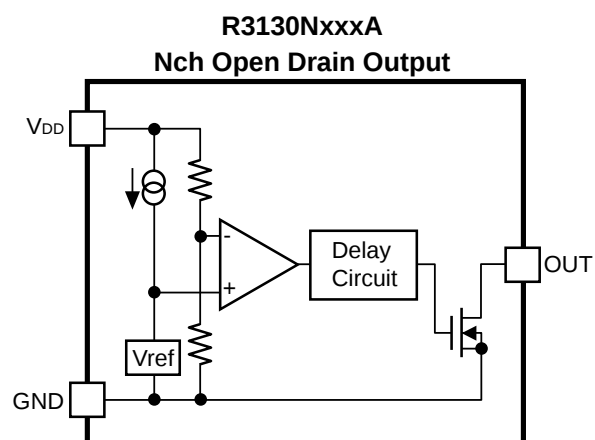
APPLICATIONS

- CPU & Logic Circuit Reset
- Battery Checker
- Window Comparator
- Wave Shaping Circuit
- Battery Back-Up Circuit
- Power Failure Detector

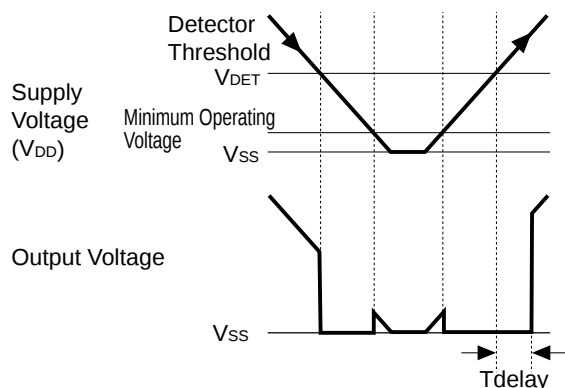
* R3130NxxB/D/H (SOT23-3) are the limited products and R3131N (SOT-23-3) is the discontinued product as of March, 2016.

R3130N/R3131N

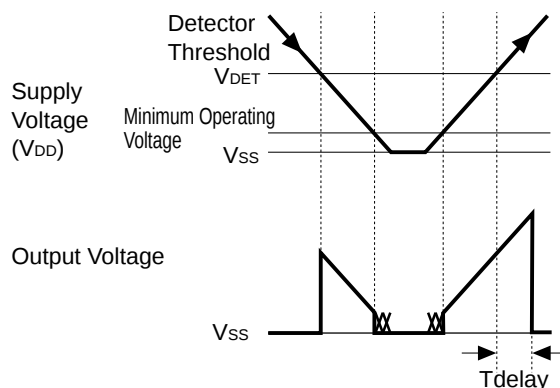
BLOCK DIAGRAMS



TIMING CHART



R3130N Operation Diagram



R3131N Operation Diagram

• Output Delay Operation

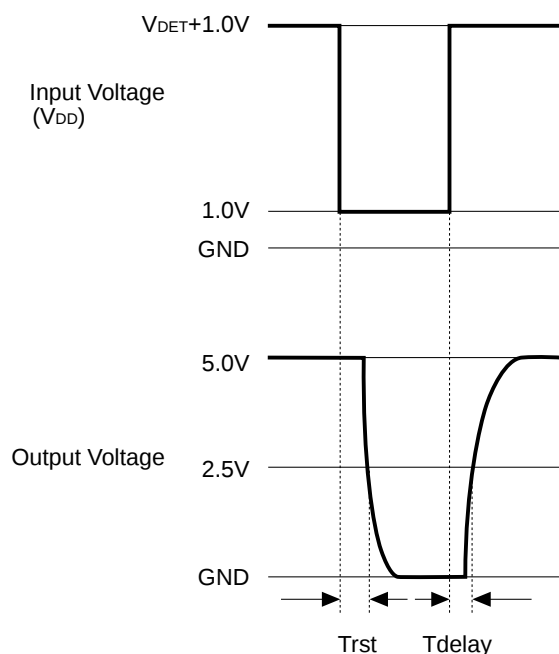
Output Delay Time, or T_{delay} is specified as follows:

1. In the case of Nch open drain output:

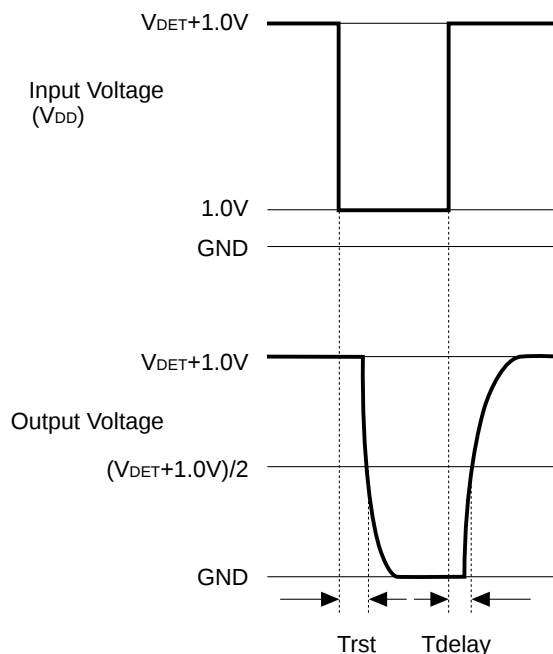
The time interval from rising edge of V_{DD} pulse ($1.0V \rightarrow (V_{DET}+1.0V)$) to the time at which the output reaches 2.5V under the condition that the output pin (OUT) is pulled up to 5V through a 470k Ω resistor.

2. In the case of CMOS output

The time interval from rising edge of V_{DD} pulse ($1.0V \rightarrow (V_{DET}+1.0V)$) to the time at which the output reaches $V_{DD}/2$.



Nch Open Drain Output



CMOS Output

* R3130NxxB/D/H (SOT23-3) are the limited products and R3131N (SOT-23-3) is the discontinued product as of March, 2016.

R3130N/R3131N

SELECTION GUIDE

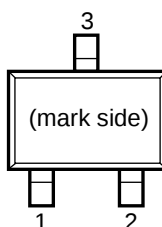
The detector threshold, the output type for the ICs can be selected at the users' request.

Product Name	Package	Quantity per Reel	Pb Free	Halogen Free
R3130Nxx\$(y)-TR-FE	SOT-23-3	3,000 pcs	Yes	Yes
R3131Nxx\$(y)-TR-FE	SOT-23-3	3,000 pcs	Yes	Yes

xx: The detector threshold can be designated in the range from 1.6V(16) to 4.8V(48) in 0.1V steps.
y: If the detector threshold includes the 3rd digit, indicate the digit of 0.01V.
(Example) If the detector threshold is 2.63V, R3130N26\$*3-TR-FE
The following 6 kinds of voltage are standard products. 2.63V, 2.93V, 3.08V, 4.0V, 4.4V, 4.65V.
\$: Designation of Output Delay Time
(A) 50ms (Only for standard products)
(B) 100ms
(D) 200ms
(E) 240ms
(H) 400ms
* : Designation of Output Type
(A) Nch Open Drain
(C) CMOS

PIN CONFIGURATION

● SOT-23-3



PIN DESCRIPTION

Pin No	Symbol	Description
1	GND	Ground Pin
2	OUT	Output Pin R3130N : Output "L" at detection mode, Output "H" at release mode R3131N : Output "H" at detection mode, Output "L" at release mode
3	V _{DD}	Input Pin

ABSOLUTE MAXIMUM RATINGS

Symbol	Item	Rating		Unit
V_{DD}	Supply Voltage	6.5		V
V_{OUT}	Output Voltage	CMOS	$V_{SS}-0.3$ to $V_{DD}+0.3$	V
		Nch	$V_{SS}-0.3$ to 6.5	V
I_{OUT}	Output Current	20		mA
P_D	Power Dissipation	150		mW
T_{opt}	Operating Temperature Range	-40 to +85		°C
T_{stg}	Storage Temperature Range	-55 to +125		°C
T_{solder}	Soldering Temperature	260°C, 10s		

ABSOLUTE MAXIMUM RATINGS

Electronic and mechanical stress momentarily exceeded absolute maximum ratings may cause the permanent damages and may degrade the life time and safety for both device and system using the device in the field.

The functional operation at or over these absolute maximum ratings is not assured.

RECOMMENDED OPERATING CONDITIONS (ELECTRICAL CHARACTERISTICS)

All of electronic equipment should be designed that the mounted semiconductor devices operate within the recommended operating conditions. The semiconductor devices cannot operate normally over the recommended operating conditions, even if when they are used over such conditions by momentary electronic noise or surge. And the semiconductor devices may receive serious damage when they continue to operate over the recommended operating conditions.

ELECTRICAL CHARACTERISTICS

• R3130N26xx3-TR

[$T_{opt}=25^{\circ}\text{C}$]

Symbol	Item	Conditions	Min.	Typ.	Max.	Unit
V_{DDH}	Maximum Operating Voltage				6.0	V
V_{DDL}^{*1}	Minimum Operating Voltage	$I_{OL}=50\mu\text{A}$		0.75	1.00	V
V_{DET}	Detector Threshold		2.591	2.630	2.669	V
I_{SS1}	Supply Current1	$V_{DD}=6.00\text{V}$		1.40	5.00	μA
I_{SS2}	Supply Current2	$V_{DD}=2.73\text{V}$		1.25	4.00	μA
I_{SS3}	Supply Current3	$V_{DD}=2.53\text{V}$		1.10	3.50	μA
V_{OH}	"H" Output Voltage	$V_{DD}=2.73\text{V}$, $I_{OUT}=-500\mu\text{A}$	$0.8 \times V_{DD}$	$0.93 \times V_{DD}$		V
V_{OL}	"L" Output Voltage	$V_{DD}=2.53\text{V}$, $I_{OUT}=1.2\text{Ma}$		0.16	0.30	V
T_{delay}^{*2}	Output Delay Time for release	Refer to electrical characteristics by Output Delay Time for release				
$\Delta V_{DET}/\Delta T_{opt}$	Detector Threshold Temperature Coefficient	$-40^{\circ}\text{C} \leq T_{opt} \leq 85^{\circ}\text{C}$		± 100		ppm/°C

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R3130N/R3131N

• R3130N29xx3-TR

[T_{opt}=25°C]

Symbol	Item	Conditions	Min.	Typ.	Max.	Unit
V _{DDH}	Maximum Operating Voltage				6.0	V
V _{DDL} *1	Minimum Operating Voltage	I _{OL} =50μA		0.75	1.00	V
V _{DET}	Detector Threshold		2.887	2.930	2.973	V
I _{SS1}	Supply Current1	V _{DD} =6.00V		1.40	5.00	μA
I _{SS2}	Supply Current2	V _{DD} =3.03V		1.25	4.00	μA
I _{SS3}	Supply Current3	V _{DD} =2.83V		1.10	3.50	μA
V _{OH}	“H” Output Voltage	V _{DD} =3.03V, I _{OUT} =−500μA	0.8×V _{DD}	0.93×V _{DD}		V
V _{OL}	“L” Output Voltage	V _{DD} =2.83V, I _{OUT} =1.2mA		0.16	0.30	V
T _{delay} *2	Output Delay Time for release	Refer to electrical characteristics by Output Delay Time for release				
ΔV _{DET} / ΔT _{opt}	Detector Threshold Temperature Coefficient	−40°C ≤ T _{opt} ≤ 85°C		±100		ppm/°C

• R3130N30xx8-TR

[T_{opt}=25°C]

Symbol	Item	Conditions	Min.	Typ.	Max.	Unit
V _{DDH}	Maximum Operating Voltage				6.0	V
V _{DDL} *1	Minimum Operating Voltage	I _{OL} =50μA		0.75	1.00	V
V _{DET}	Detector Threshold		3.034	3.080	3.126	V
I _{SS1}	Supply Current1	V _{DD} =6.00V		1.40	5.00	μA
I _{SS2}	Supply Current2	V _{DD} =3.18V		1.25	4.00	μA
I _{SS3}	Supply Current3	V _{DD} =2.98V		1.10	3.50	μA
V _{OH}	“H” Output Voltage	V _{DD} =3.18V, I _{OUT} =−500μA	0.8×V _{DD}	0.93×V _{DD}		V
V _{OL}	“L” Output Voltage	V _{DD} =2.98V, I _{OUT} =1.2mA		0.16	0.30	V
T _{delay} *2	Output Delay Time for release	Refer to electrical characteristics by Output Delay Time for release				
ΔV _{DET} / ΔT _{opt}	Detector Threshold Temperature Coefficient	−40°C ≤ T _{opt} ≤ 85°C		±100		ppm/°C

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R3130N/R3131N

• R3130N40xx-TR

[T_{opt}=25°C]

Symbol	Item	Conditions	Min.	Typ.	Max.	Unit
V _{DDH}	Maximum Operating Voltage				6.0	V
V _{DDL} *1	Minimum Operating Voltage	I _{OL} =50μA		0.75	1.00	V
V _{DET}	Detector Threshold		3.940	4.000	4.060	V
I _{SS1}	Supply Current1	V _{DD} =6.00V		1.40	5.00	μA
I _{SS2}	Supply Current2	V _{DD} =4.10V		1.30	4.00	μA
I _{SS3}	Supply Current3	V _{DD} =3.90V		1.15	3.50	μA
V _{OH}	“H” Output Voltage	V _{DD} =4.10V, I _{OUT} =−800μA	0.8×V _{DD}	0.95×V _{DD}		V
V _{OL}	“L” Output Voltage	V _{DD} =3.90V, I _{OUT} =3.2mA		0.18	0.40	V
T _{delay} *2	Output Delay Time for release	Refer to electrical characteristics by Output Delay Time for release				
ΔV _{DET} / ΔT _{opt}	Detector Threshold Temperature Coefficient	−40°C ≤ T _{opt} ≤ 85°C		±100		ppm/°C

• R3130N44xx-TR

[T_{opt}=25°C]

Symbol	Item	Conditions	Min.	Typ.	Max.	Unit
V _{DDH}	Maximum Operating Voltage				6.0	V
V _{DDL} *1	Minimum Operating Voltage	I _{OL} =50μA		0.75	1.00	V
V _{DET}	Detector Threshold		4.334	4.400	4.466	V
I _{SS1}	Supply Current1	V _{DD} =6.00V		1.40	5.00	μA
I _{SS2}	Supply Current2	V _{DD} =4.50V		1.30	4.00	μA
I _{SS3}	Supply Current3	V _{DD} =4.30V		1.15	3.50	μA
V _{OH}	“H” Output Voltage	V _{DD} =4.50V, I _{OUT} =−800μA	0.8×V _{DD}	0.95×V _{DD}		V
V _{OL}	“L” Output Voltage	V _{DD} =4.30V, I _{OUT} =3.2mA		0.18	0.40	V
T _{delay} *2	Output Delay Time for release	Refer to electrical characteristics by Output Delay Time for release				
ΔV _{DET} / ΔT _{opt}	Detector Threshold Temperature Coefficient	−40°C ≤ T _{opt} ≤ 85°C		±100		ppm/°C

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R3130N/R3131N

• R3130N46xx5-TR

[T_{opt}=25°C]

Symbol	Item	Conditions	Min.	Typ.	Max.	Unit
V _{DDH}	Maximum Operating Voltage				6.0	V
V _{DDL} *1	Minimum Operating Voltage	I _{OL} =50μA		0.75	1.00	V
V _{DET}	Detector Threshold		4.581	4.650	4.719	V
I _{SS1}	Supply Current1	V _{DD} =6.00V		1.40	5.00	μA
I _{SS2}	Supply Current2	V _{DD} =4.75V		1.30	4.00	μA
I _{SS3}	Supply Current3	V _{DD} =4.55V		1.15	3.50	μA
V _{OH}	“H” Output Voltage	V _{DD} =4.75V, I _{OUT} =−800μA	0.8×V _{DD}	0.95×V _{DD}		V
V _{OL}	“L” Output Voltage	V _{DD} =4.55V, I _{OUT} =3.2mA		0.18	0.40	V
T _{delay} *2	Output Delay Time for release	Refer to electrical characteristics by Output Delay Time for release				
ΔV _{DET} / ΔT _{opt}	Detector Threshold Temperature Coefficient	−40°C ≤ T _{opt} ≤ 85°C		±100		ppm/°C

• R3131N26xx3-TR

[T_{opt}=25°C]

Symbol	Item	Conditions		Min.	Typ.	Max.	Unit
V _{DDH}	Maximum Operating Voltage					6.0	V
V _{DDL} *3	Minimum Operating Voltage	CMOS Output	I _{OH} =−10μA		0.90	1.00	V
		Nch Open Drain Output	V _{DS} =6.5V				
V _{DET}	Detector Threshold			2.591	2.630	2.669	V
I _{SS1}	Supply Current1	V _{DD} =6.00V			1.40	5.00	μA
I _{SS2}	Supply Current2	V _{DD} =2.73V			1.25	4.00	μA
I _{SS3}	Supply Current3	V _{DD} =2.53V			1.10	3.50	μA
V _{OH}	“H” Output Voltage	V _{DD} =2.73V, I _{OUT} =−500μA		0.8×V _{DD}	0.93×V _{DD}		V
V _{OL}	“L” Output Voltage	V _{DD} =2.53V, I _{OUT} =1.2mA			0.16	0.30	V
T _{delay} *2	Output Delay Time for release	Refer to electrical characteristics by Output Delay Time for release					
ΔV _{DET} / ΔT _{opt}	Detector Threshold Temperature Coefficient	−40°C ≤ T _{opt} ≤ 85°C			±100		ppm/°C

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R3130N/R3131N

• R3131N29xx3-TR

[T_{opt}=25°C]

Symbol	Item	Conditions		Min.	Typ.	Max.	Unit
V _{DDH}	Maximum Operating Voltage					6.0	V
V _{DDL} *3	Minimum Operating Voltage	CMOS Output	I _{OH} =-10μA		0.90	1.00	V
		Nch Open Drain Output	V _{DS} =6.5V				
V _{DET}	Detector Threshold			2.887	2.930	2.973	V
I _{SS1}	Supply Current1	V _{DD} =6.00V			1.40	5.00	μA
I _{SS2}	Supply Current2	V _{DD} =3.03V			1.25	4.00	μA
I _{SS3}	Supply Current3	V _{DD} =2.83V			1.10	3.50	μA
V _{OH}	"H" Output Voltage	V _{DD} =2.83V, I _{OUT} =-500μA		0.8×V _{DD}	0.93×V _{DD}		V
V _{OL}	"L" Output Voltage	V _{DD} =3.03V, I _{OUT} =1.2mA			0.16	0.30	V
T _{delay} *2	Output Delay Time for release	Refer to electrical characteristics by Output Delay Time for release					
ΔV _{DET} / ΔT _{opt}	Detector Threshold Temperature Coefficient	-40°C ≤ T _{opt} ≤ 85°C			±100		ppm/°C

• R3131N30xx8-TR

[T_{opt}=25°C]

Symbol	Item	Conditions		Min.	Typ.	Max.	Unit
V _{DDH}	Maximum Operating Voltage					6.0	V
V _{DDL} *3	Minimum Operating Voltage	CMOS Output	I _{OH} =-10μA		0.90	1.00	V
		Nch Open Drain Output	V _{DS} =6.5V				
V _{DET}	Detector Threshold			3.034	3.080	3.126	V
I _{SS1}	Supply Current1	V _{DD} =6.00V			1.40	5.00	μA
I _{SS2}	Supply Current2	V _{DD} =3.18V			1.25	4.00	μA
I _{SS3}	Supply Current3	V _{DD} =2.98V			1.10	3.50	μA
V _{OH}	"H" Output Voltage	V _{DD} =2.98V, I _{OUT} =-500μA		0.8×V _{DD}	0.93×V _{DD}		V
V _{OL}	"L" Output Voltage	V _{DD} =3.18V, I _{OUT} =1.2mA			0.16	0.30	V
T _{delay} *2	Output Delay Time for release	Refer to electrical characteristics by Output Delay Time for release					
ΔV _{DET} / ΔT _{opt}	Detector Threshold Temperature Coefficient	-40°C ≤ T _{opt} ≤ 85°C			±100		ppm/°C

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R3130N/R3131N

• R3131N40xx-TR

[T_{opt}=25°C]

Symbol	Item	Conditions		Min.	Typ.	Max.	Unit
V _{DDH}	Maximum Operating Voltage					6.0	V
V _{DDL} *3	Minimum Operating Voltage	CMOS Output	I _{OH} =-10μA		0.90	1.00	V
		Nch Open Drain Output	V _{DS} =6.5V				
V _{DET}	Detector Threshold			3.940	4.000	4.060	V
I _{SS1}	Supply Current1	V _{DD} =6.00V			1.40	5.00	μA
I _{SS2}	Supply Current2	V _{DD} =3.90V			1.30	4.00	μA
I _{SS3}	Supply Current3	V _{DD} =4.10V			1.15	3.50	μA
V _{OH}	"H" Output Voltage	V _{DD} =3.90V, I _{OUT} =-800μA		0.8×V _{DD}	0.95×V _{DD}		V
V _{OL}	"L" Output Voltage	V _{DD} =4.10V, I _{OUT} =3.2mA			0.18	0.40	V
Tdelay *2	Output Delay Time for release	Refer to electrical characteristics by Output Delay Time for release					
ΔV _{DET} / ΔT _{opt}	Detector Threshold Temperature Coefficient	-40°C ≤ T _{opt} ≤ 85°C			±100		ppm/°C

• R3131N44xx-TR

[T_{opt}=25°C]

Symbol	Item	Conditions		Min.	Typ.	Max.	Unit
V _{DDH}	Maximum Operating Voltage					6.0	V
V _{DDL} *3	Minimum Operating Voltage	CMOS Output	I _{OH} =-10μA		0.90	1.00	V
		Nch Open Drain Output	V _{DS} =6.5V				
V _{DET}	Detector Threshold			4.334	4.400	4.466	V
I _{SS1}	Supply Current1	V _{DD} =6.00V			1.40	5.00	μA
I _{SS2}	Supply Current2	V _{DD} =4.50V			1.30	4.00	μA
I _{SS3}	Supply Current3	V _{DD} =4.30V			1.15	3.50	μA
V _{OH}	"H" Output Voltage	V _{DD} =4.30V, I _{OUT} =-800μA		0.8×V _{DD}	0.95×V _{DD}		V
V _{OL}	"L" Output Voltage	V _{DD} =4.50V, I _{OUT} =3.2mA			0.18	0.40	V
Tdelay *2	Output Delay Time for release	Refer to electrical characteristics by Output Delay Time for release					
ΔV _{DET} / ΔT _{opt}	Detector Threshold Temperature Coefficient	-40°C ≤ T _{opt} ≤ 85°C			±100		ppm/°C

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R3130N/R3131N

● R3131N46xx5-TR

[T_{opt}=25°C]

Symbol	Item	Conditions	Min.	Typ.	Max.	Unit
V _{DDH}	Maximum Operating Voltage				6.0	V
V _{DDL} *3	Minimum Operating Voltage	CMOS Output I _{OH} =-10μA		0.90	1.00	V
		Nch Open Drain Output V _{DS} =6.5V				
V _{DET}	Detector Threshold		4.581	4.650	4.719	V
I _{SS1}	Supply Current1	V _{DD} =6.00V		1.40	5.00	μA
I _{SS2}	Supply Current2	V _{DD} =4.75V		1.30	4.00	μA
I _{SS3}	Supply Current3	V _{DD} =4.55V		1.15	3.50	μA
V _{OH}	"H" Output Voltage	V _{DD} =4.55V, I _{OUT} =-800μA	0.8×V _{DD}	0.95×V _{DD}		V
V _{OL}	"L" Output Voltage	V _{DD} =4.75V, I _{OUT} =3.2mA		0.18	0.40	V
T _{delay} *2	Output Delay Time for release	Refer to electrical characteristics by Output Delay Time for release				
ΔV _{DET} / ΔT _{opt}	Detector Threshold Temperature Coefficient	-40°C ≤ T _{opt} ≤ 85°C		±100		ppm/°C

*1) Supply Voltage when Output Voltage becomes equal or less than 0.3V. (As for Nch Open Drain Output type, pull-up resistor is 470kΩ, pull-up voltage is 5.0V.

*2) Time interval of rising edge of V_{DD} which is set from 1.0V to V_{DET}+1.0V, and the point of which Output voltage reaches to 50% of final voltage.

*3) CMOS Output type; Supply Voltage when Output Voltage becomes equal or more than 0.8×V_{DD}.
Nch Open Drain type; Supply Voltage when off leakage current becomes equal or less than 0.1μA.

ELECTRICAL CHARACTERISTICS BY OUTPUT DELAY TIME

[T_{opt}=25°C]

Part Number	Test Condition	Output Delay Time (T _{delay})			Unit
		Min.	Typ.	Max.	
R313xNxxAx	V _{DD} =1.0V to V _{DET} +1.0V	45	50	55	ms
R313xNxxBx		90	100	110	
R313xNxxDx		180	200	220	
R313xNxxEx		216	240	264	
R313xNxxHx		360	400	440	

* R3130NxxB/D/H (SOT23-3) are the limited products and R3131N (SOT-23-3) is the discontinued product as of March, 2016.

R3130N/R3131N

ELECTRICAL CHARACTERISTICS BY DETECTOR THRESHOLD

• R3130N16EA/C to R3130N48EA/C

Part Number	Detector Threshold			Supply Current 1			Supply Current 2			Supply Current 3				
	V _{DET} (V)			I _{SS1} (μA)			I _{SS2} (μA)			I _{SS3} (μA)				
	Min.	Typ.	Max.	Condition	Typ.	Max.	Condition	Typ.	Max.	Condition	Typ.	Max.		
R3130N16EA/C	1.576	1.600	1.624	V _{DD} =6.0V	1.40	5.00	V _{DD} =V _{DET} +0.1V	1.20	4.00	V _{DD} =V _{DET} -0.1V	1.00	3.50		
R3130N17EA/C	1.675	1.700	1.725											
R3130N18EA/C	1.773	1.800	1.827											
R3130N19EA/C	1.872	1.900	1.928											
R3130N20EA/C	1.970	2.000	2.030											
R3130N21EA/C	2.069	2.100	2.131											
R3130N22EA/C	2.167	2.200	2.233											
R3130N23EA/C	2.266	2.300	2.334											
R3130N24EA/C	2.364	2.400	2.436					1.25			1.10			
R3130N25EA/C	2.463	2.500	2.537											
R3130N26EA/C	2.561	2.600	2.639											
R3130N27EA/C	2.660	2.700	2.740											
R3130N28EA/C	2.758	2.800	2.842											
R3130N29EA/C	2.857	2.900	2.943											
R3130N30EA/C	2.955	3.000	3.045											
R3130N31EA/C	3.054	3.100	3.146											
R3130N32EA/C	3.152	3.200	3.248											
R3130N33EA/C	3.251	3.300	3.349											
R3130N34EA/C	3.349	3.400	3.451											
R3130N35EA/C	3.448	3.500	3.552											
R3130N36EA/C	3.546	3.600	3.654										1.30	1.15
R3130N37EA/C	3.645	3.700	3.755											
R3130N38EA/C	3.743	3.800	3.857											
R3130N39EA/C	3.842	3.900	3.958											
R3130N40EA/C	3.940	4.000	4.060											
R3130N41EA/C	4.039	4.100	4.161											
R3130N42EA/C	4.137	4.200	4.263											
R3130N43EA/C	4.236	4.300	4.364											
R3130N44EA/C	4.334	4.400	4.466											
R3130N45EA/C	4.433	4.500	4.567											
R3130N46EA/C	4.531	4.600	4.669											
R3130N47EA/C	4.630	4.700	4.770											
R3130N48EA/C	4.728	4.800	4.872											

* R3130NxxB/D/H (SOT23-3) are the limited products and R3131N (SOT-23-3) is the discontinued product as of March, 2016.

R3130N/R3131N

T_{opt}=25°C

“H” Output Voltage			“L” Output Voltage			Minimum Operating Voltage		Output Delay Time			Detector Threshold Temperature Coefficient	
V _{OH} (V)			V _{OL} (V)			V _{DDL} (V)		T _{delay} (ms)			ΔV _{DET} /ΔT _{opt} (ppm/°C)	
Condition	Min.	Typ.	Condition	Typ.	Max.	Typ.	Max.	Min.	Typ.	Max.	Condition	Typ.
V _{DD} =V _{DET} +0.1V I _{OH} = -150μA	0.80× V _{DD}	0.95× V _{DD}	V _{DD} =V _{DET} -0.1V, I _{OL} =1.2mA	0.16	0.30	*1 0.75	*1 1.00	216	240	264	-40°C ≤ T _{opt} ≤ 85°C	±100
V _{DD} =V _{DET} +0.1V I _{OH} = -500μA	0.80× V _{DD}	0.93× V _{DD}										
V _{DD} =V _{DET} +0.1V I _{OH} = -800μA	0.80× V _{DD}	0.95× V _{DD}	V _{DD} =V _{DET} -0.1V, I _{OL} =3.2mA	0.18	0.40							

*1describes V_{DD} Voltage when Output Voltage becomes equal or less than 0.3V.

* R3130NxxB/D/H (SOT23-3) are the limited products and R3131N (SOT-23-3) is the discontinued product as of March, 2016.

R3130N/R3131N

- R3131N16EA/C to R3131N48EA/C

Part Number	Detector Threshold			Supply Current 1			Supply Current 2			Supply Current 3			
	V _{DET} (V)			I _{SS1} (μA)			I _{SS2} (μA)			I _{SS3} (μA)			
	Min.	Typ.	Max.	Condition	Typ.	Max.	Condition	Typ.	Max.	Condition	Typ.	Max.	
R3131N16EA/C	1.576	1.600	1.624	V _{DD} =6.0V	1.40	5.00	V _{DD} =V _{DET} +0.1V	1.20		4.00	V _{DD} =V _{DET} −0.1V	1.00	3.50
R3131N17EA/C	1.675	1.700	1.725										
R3131N18EA/C	1.773	1.800	1.827										
R3131N19EA/C	1.872	1.900	1.928										
R3131N20EA/C	1.970	2.000	2.030										
R3131N21EA/C	2.069	2.100	2.131										
R3131N22EA/C	2.167	2.200	2.233										
R3131N23EA/C	2.266	2.300	2.334										
R3131N24EA/C	2.364	2.400	2.436					1.25		1.10			
R3131N25EA/C	2.463	2.500	2.537										
R3131N26EA/C	2.561	2.600	2.639										
R3131N27EA/C	2.660	2.700	2.740										
R3131N28EA/C	2.758	2.800	2.842										
R3131N29EA/C	2.857	2.900	2.943										
R3131N30EA/C	2.955	3.000	3.045										
R3131N31EA/C	3.054	3.100	3.146										
R3131N32EA/C	3.152	3.200	3.248					1.30		1.15			
R3131N33EA/C	3.251	3.300	3.349										
R3131N34EA/C	3.349	3.400	3.451										
R3131N35EA/C	3.448	3.500	3.552										
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R3131N37EA/C	3.645	3.700	3.755										
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R3131N39EA/C	3.842	3.900	3.958										
R3131N40EA/C	3.940	4.000	4.060										
R3131N41EA/C	4.039	4.100	4.161										
R3131N42EA/C	4.137	4.200	4.263										
R3131N43EA/C	4.236	4.300	4.364										
R3131N44EA/C	4.334	4.400	4.466										
R3131N45EA/C	4.433	4.500	4.567										
R3131N46EA/C	4.531	4.600	4.669										
R3131N47EA/C	4.630	4.700	4.770										
R3131N48EA/C	4.728	4.800	4.872										

* R3130NxxB/D/H (SOT23-3) are the limited products and R3131N (SOT-23-3) is the discontinued product as of March, 2016.

R3130N/R3131N

T_{opt}=25°C

“H” Output Voltage			“L” Output Voltage			Minimum Operating Voltage		Output Delay Time			Detector Threshold Temperature Coefficient	
V _{OH} (V)			V _{OL} (V)			V _{DDL} (V)		T _{delay} (ms)			ΔV _{DET} /ΔT _{opt} (ppm/°C)	
Condition	Min.	Typ.	Condition	Typ.	Max.	Typ.	Max.	Min.	Typ.	Max.	Condition	Typ
V _{DD} =V _{DET} −0.1V I _{OH} = −150μA	0.80× V _{DD}	0.95× V _{DD}	V _{DD} =V _{DET} +0.1V, I _{OL} =1.2mA	0.16	0.30	*2 0.90	*2 1.00	216	240	264	−40°C ≤ T _{opt} ≤ 85°C	±100
V _{DD} =V _{DET} −0.1V I _{OH} = −500μA	0.80× V _{DD}	0.93× V _{DD}										
V _{DD} =V _{DET} −0.1V I _{OH} = −800μA	0.80× V _{DD}	0.95× V _{DD}	V _{DD} =V _{DET} +0.1V, I _{OL} =3.2mA	0.18	0.40							

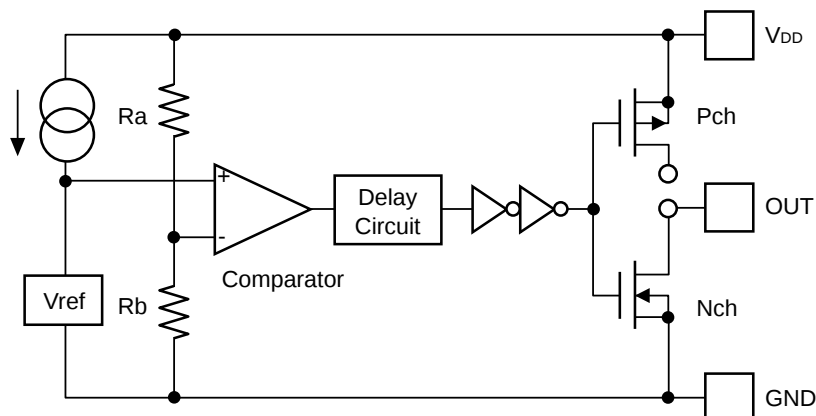
*2 CMOS Output Type; describes V_{DD} voltage when Output Voltage becomes equal or more than V_{DD}×0.8V

Nch Open Drain Output Type; describes V_{DD} voltage when Off-leakage Current becomes equal or less than 0.1μA.

R3130N/R3131N

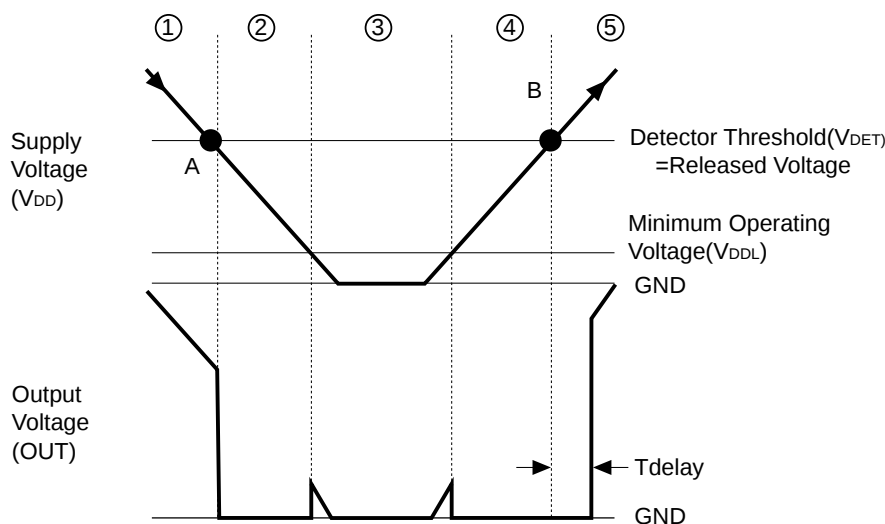
OPERATION

• Operation of R3130N Series



- CMOS output type
OUT pin is connected to the drain of Nch Tr. and Pch Tr. in this IC.
- Nch open drain output type
OUT pin is connected to the drain of Nch Tr. in this IC. (OUT pin should be pulled up to V_{DD} or an external voltage level.)

Block Diagram



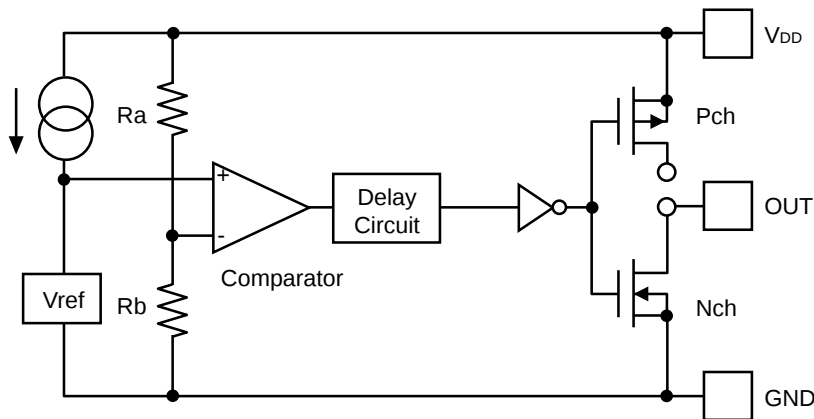
Operating Diagram

In the above diagram,

- ① Output voltage becomes equal to supply voltage (Nch open drain output Type; equal to pull-up Voltage).
- ② When supply voltage is down to the detector threshold level (Point A), $V_{ref} \geq V_{DD} \times R_b / (R_a + R_b)$ is true. Then, Output of the comparator is reversed, thus output voltage becomes equal to GND level.
- ③ When supply voltage is lower than minimum operating voltage, output of transistor is indefinite, therefore output is also indefinite.
- ④ Output voltage is equal to GND level.
- ⑤ When supply voltage is higher than released voltage (Point B), $V_{ref} \leq V_{DD} \times R_b / (R_a + R_b)$ is true. Then output of the comparator is reversed, thus output voltage becomes equal to supply voltage (Nch open drain output type; equal to pull-up voltage).

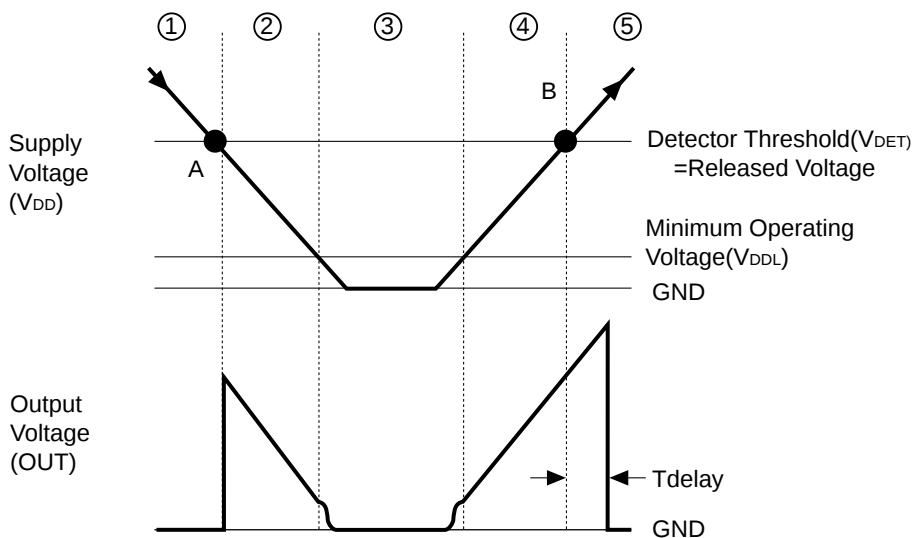
* There is no hysteresis range between detector threshold and released voltage.

• Operation of R3131N Series



- CMOS output type
OUT pin is connected to the drain of Nch Tr. and Pch Tr. in this IC.
- Nch open drain output type: I
OUT pin is connected to the drain of Nch Tr. in this IC. (OUT pin should be pulled up to VDD or an external voltage level.)

Block Diagram



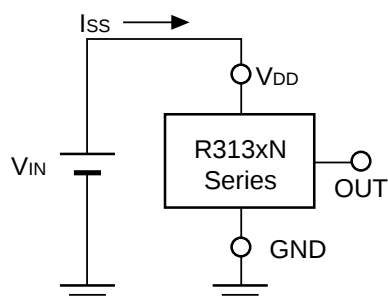
Operation Diagram

In the above diagram,

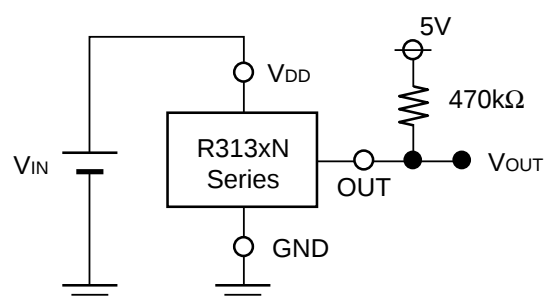
- ① Output voltage becomes equal to GND level.
 - ② When supply voltage is down to the detector threshold level (Point A), $V_{ref} \geq V_{DD} \times R_b / (R_a + R_b)$ is true. Then, output of the comparator is reversed, thus output voltage becomes equal to supply voltage (Nch open drain output type; equal to pull-up Voltage).
 - ③ When supply voltage is lower than minimum operating voltage, Output of transistor is indefinite, therefore output is also indefinite. (Nch open drain output type; Output voltage level is equal to pull-up voltage.)
 - ④ Output voltage is equal to supply voltage. (Nch open drain output type; equal to pull-up voltage.)
 - ⑤ When supply voltage is higher than released voltage (Point B), $V_{ref} \leq V_{DD} \times R_b / (R_a + R_b)$ is true. Then output of the comparator is reversed, thus output voltage becomes equal to GND level after the output delay time.
- * There is no hysteresis range between detector threshold and released voltage.

R3130N/R3131N

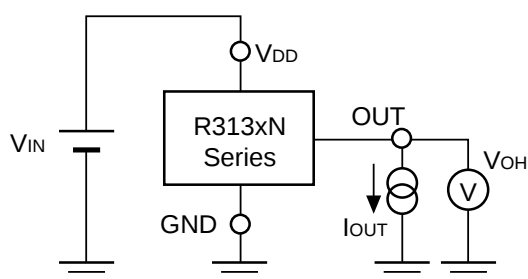
TEST CIRCUITS



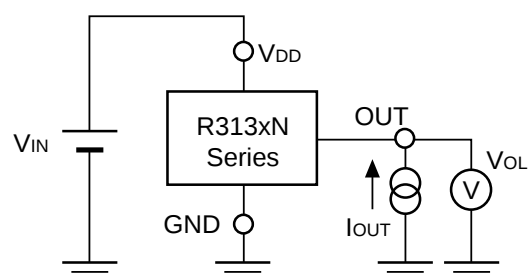
Test Circuit for Supply Current



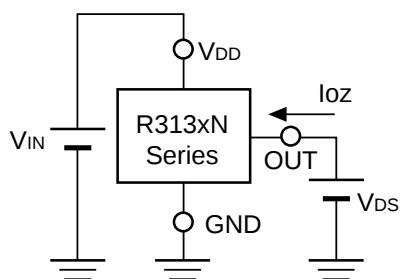
Test Circuit for Detector Threshold
(CMOS Output type; pull-up part is not necessary.)



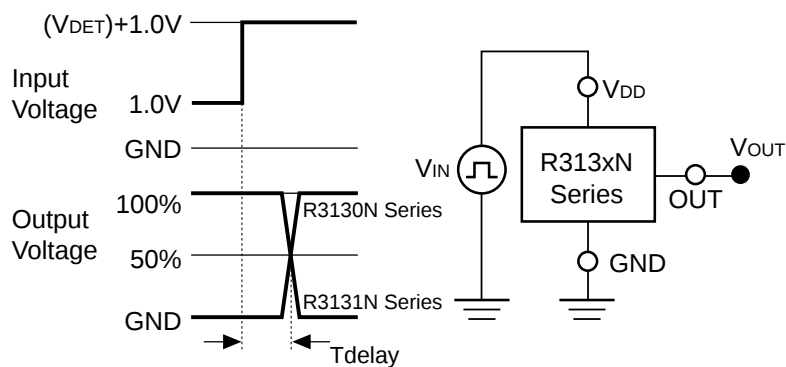
Test Circuit for "H" Output Voltage
(CMOS Output Type only)



Test Circuit for "L" Output Voltage



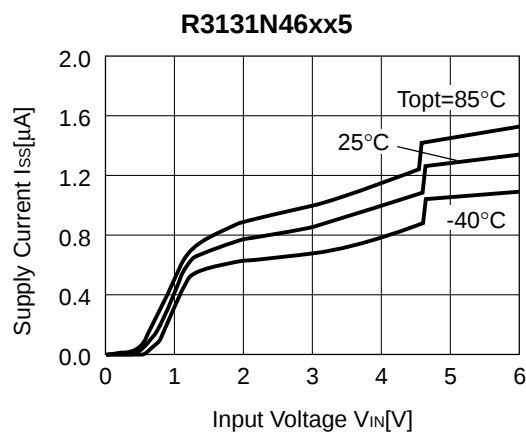
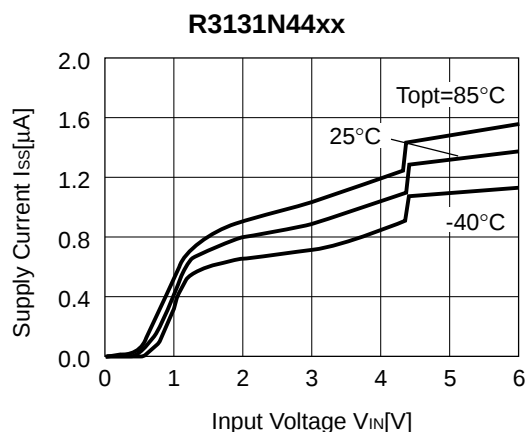
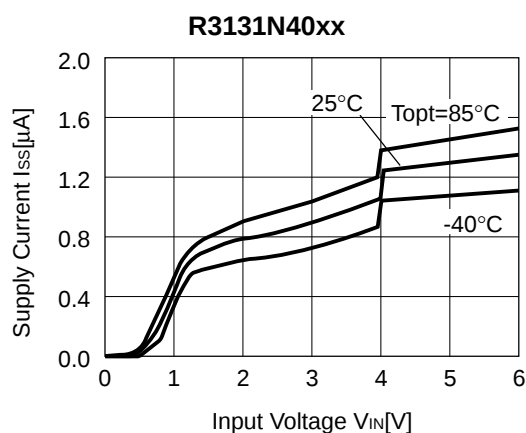
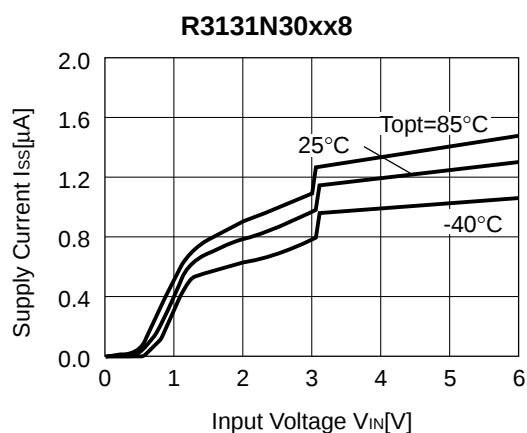
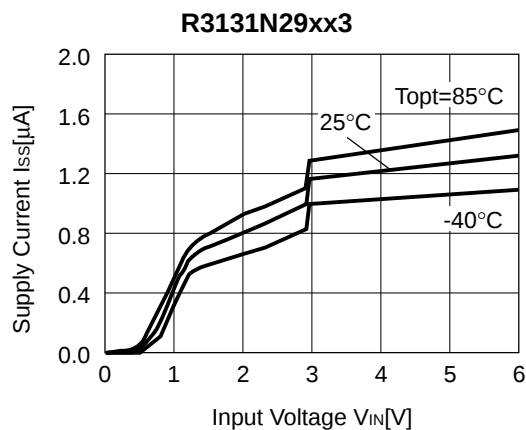
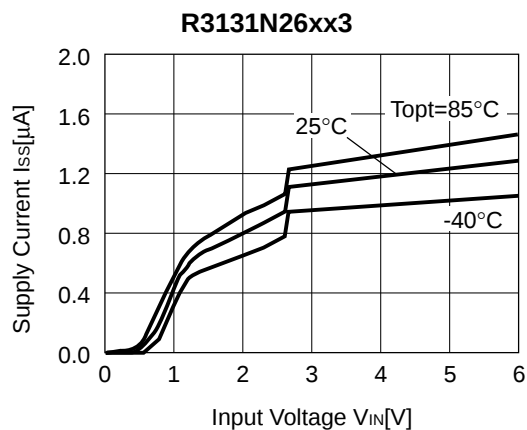
Test Circuit for Off Leakage Current



Test Circuit for Output Delay Time
(CMOS Output type; pull-up is not necessary.)

TYPICAL CHARACTERISTICS

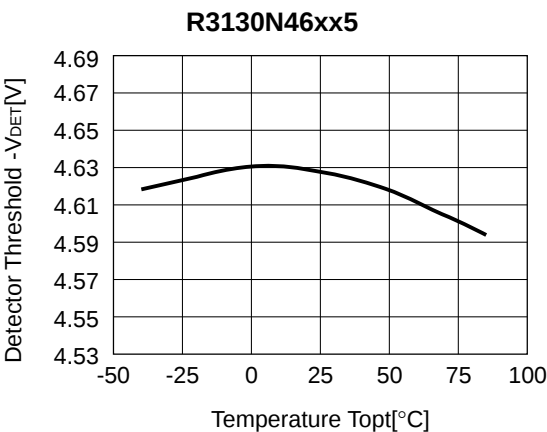
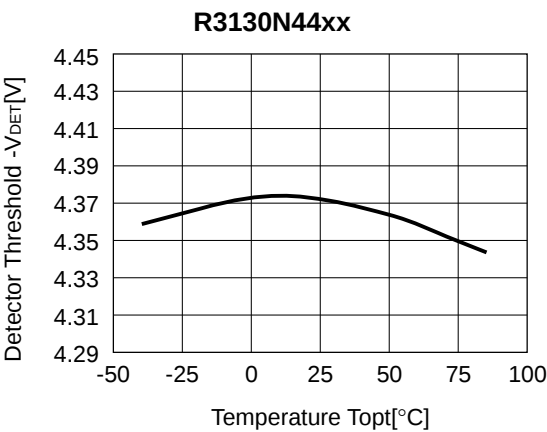
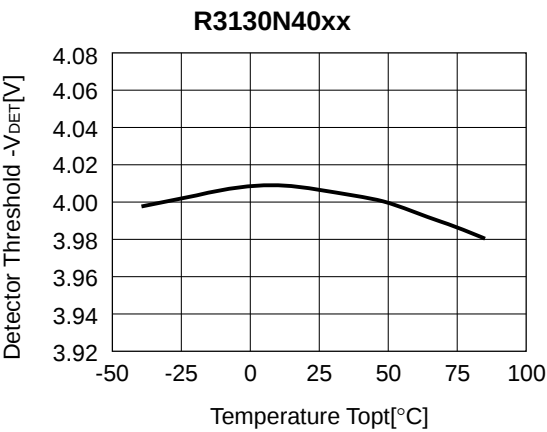
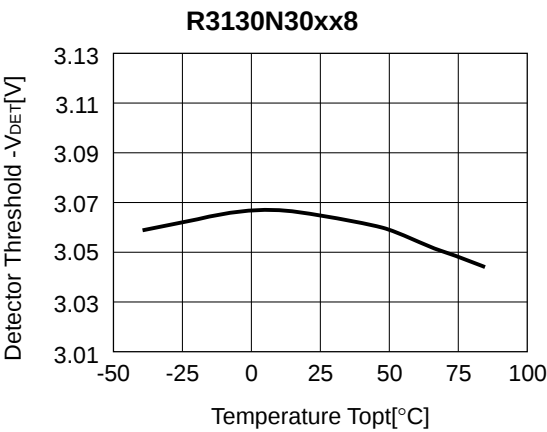
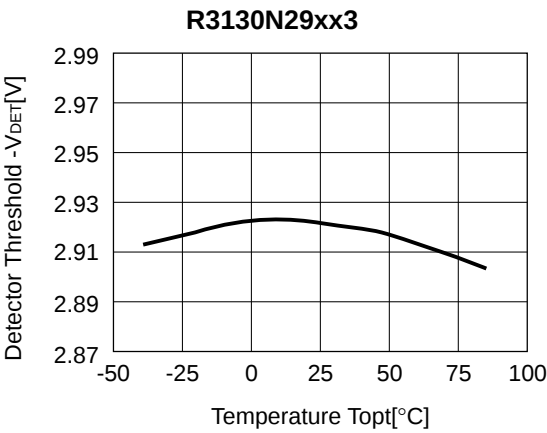
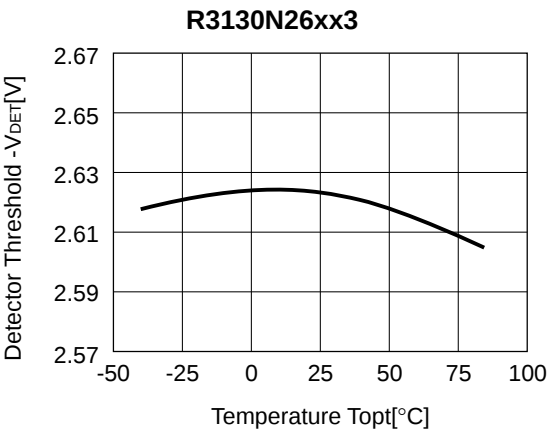
1) Supply Current vs. Input Voltage



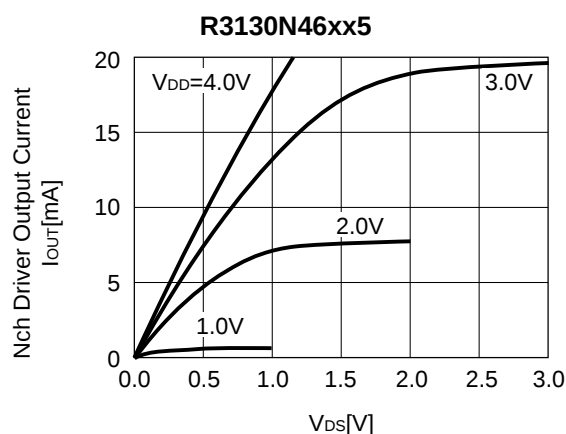
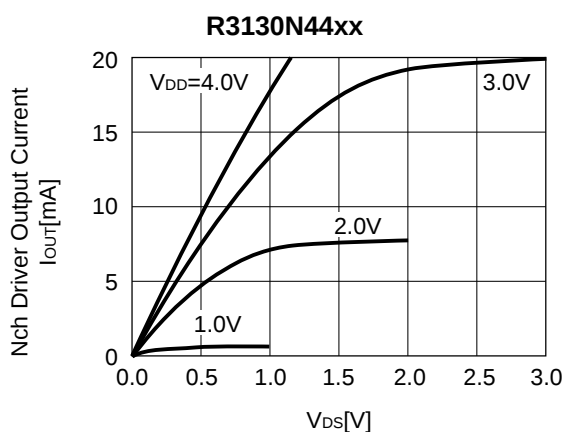
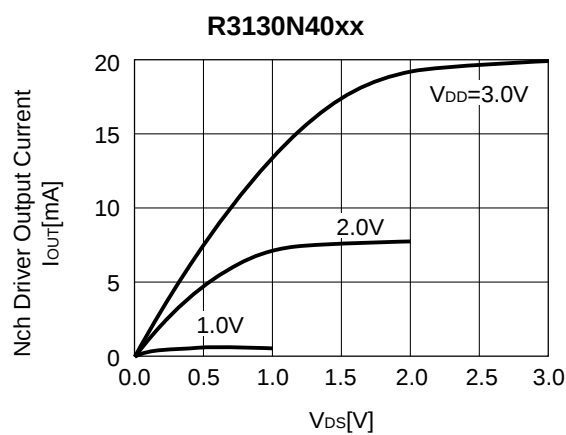
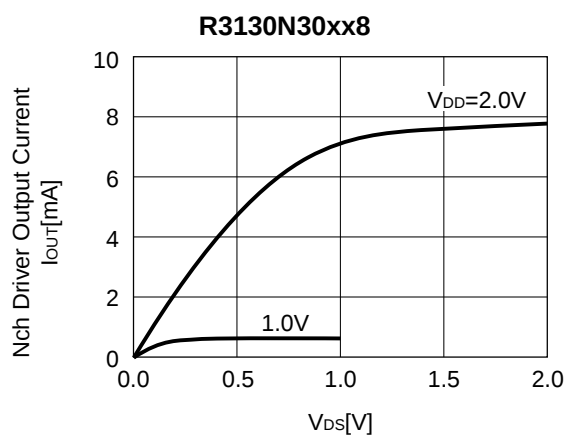
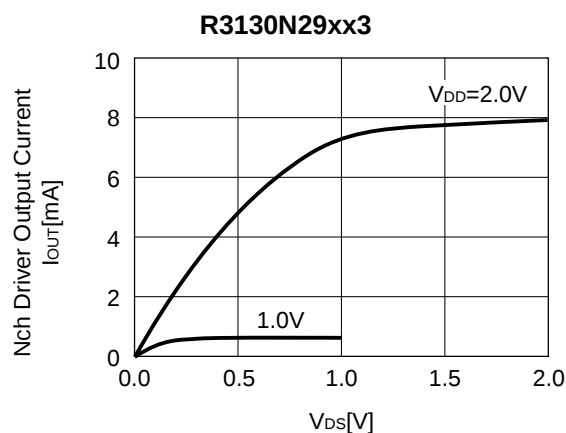
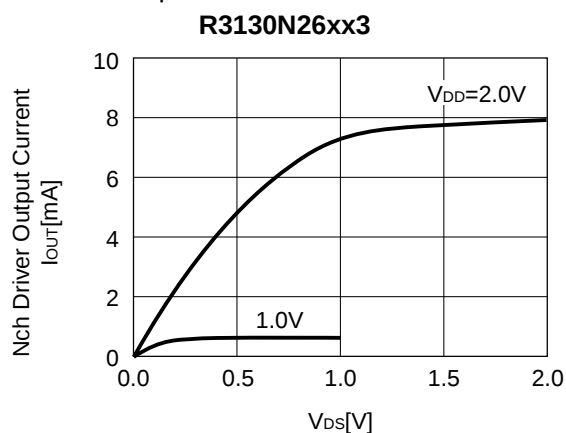
* R3130NxxB/D/H (SOT23-3) are the limited products and R3131N (SOT-23-3) is the discontinued product as of March, 2016.

R3130N/R3131N

2) Detector Threshold vs. Temperature

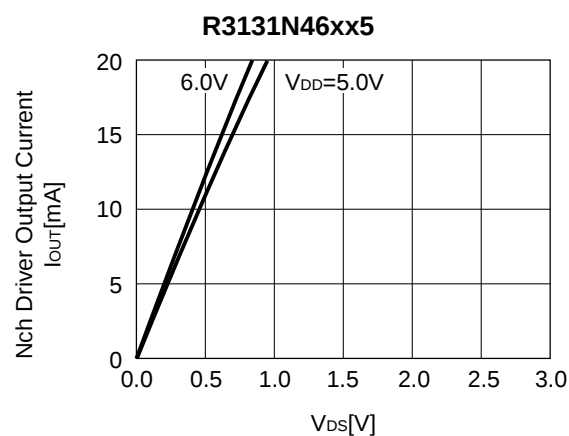
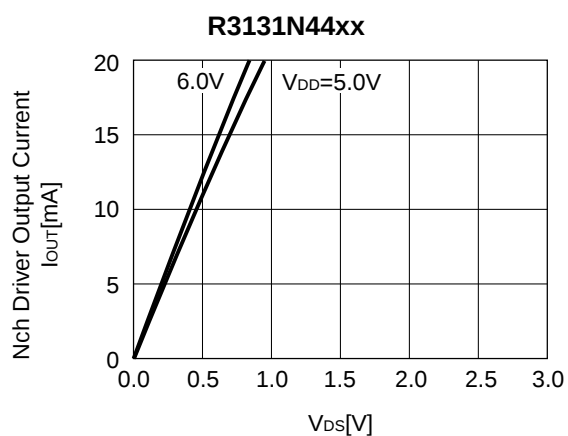
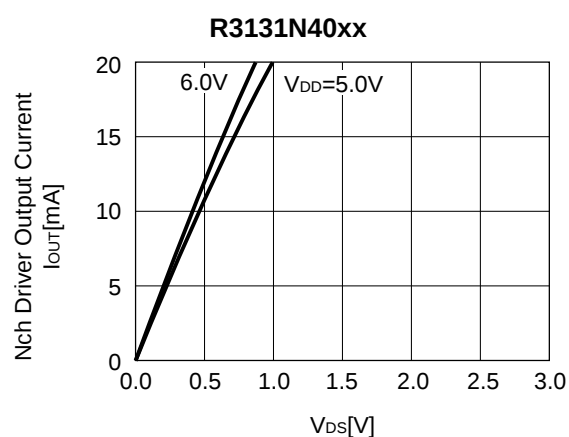
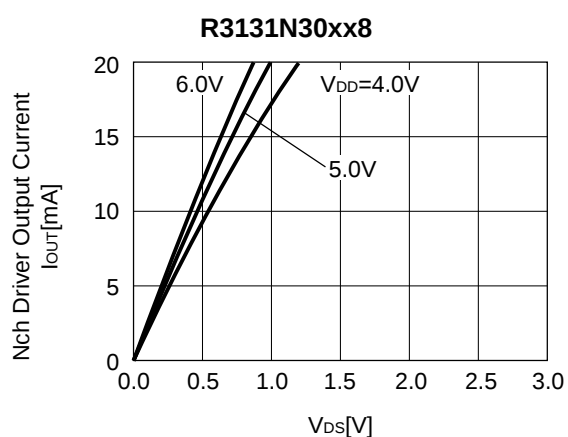
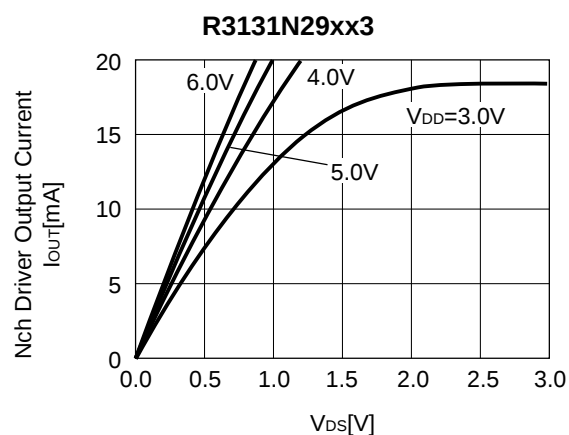
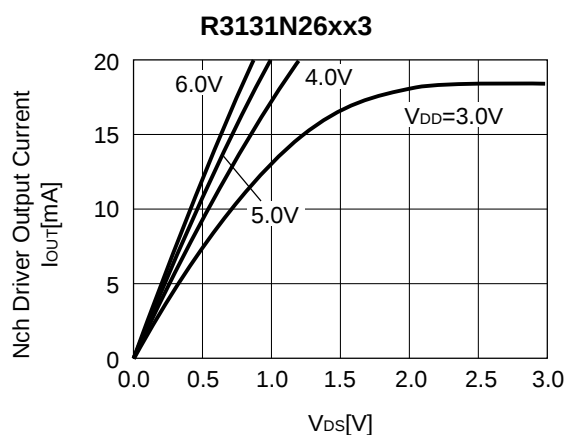


3) Nch Driver Output Current vs. V_{DS}



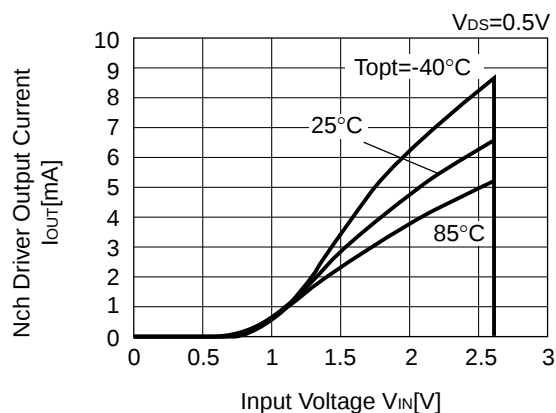
* R3130NxxB/D/H (SOT23-3) are the limited products and R3131N (SOT-23-3) is the discontinued product as of March, 2016.

R3130N/R3131N

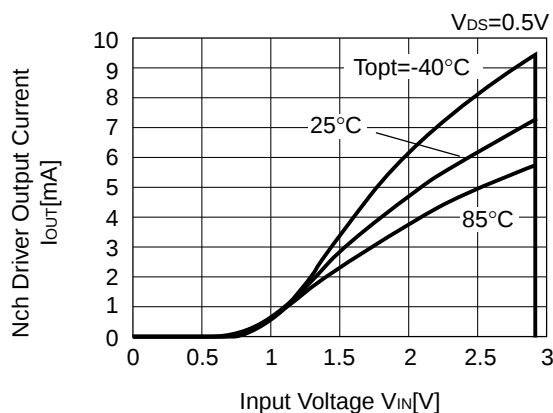


4) Nch Driver Output Current vs. Input Voltage

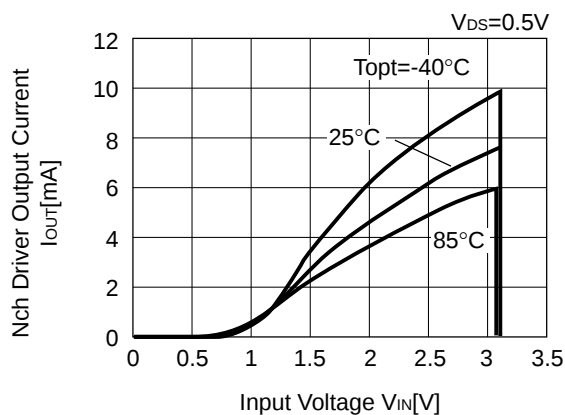
R3130N26xx3



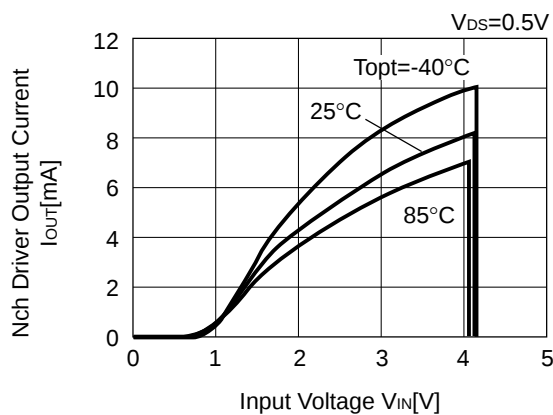
R3130N29xx3



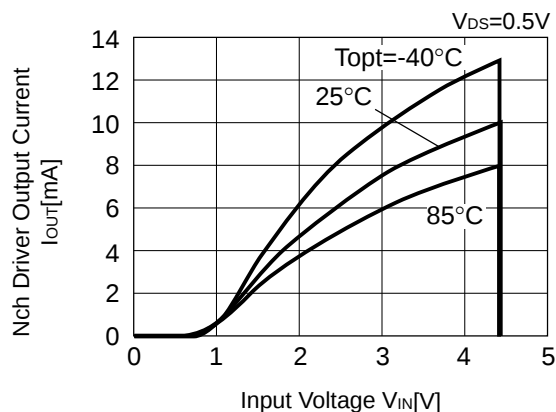
R3130N30xx8



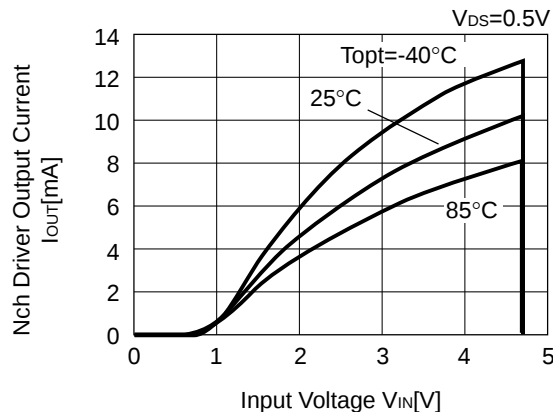
R3130N40xx



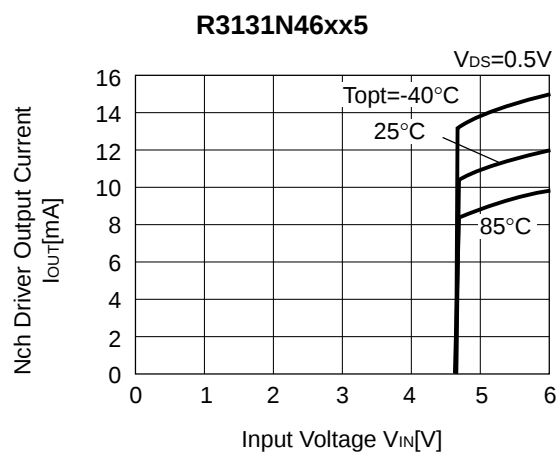
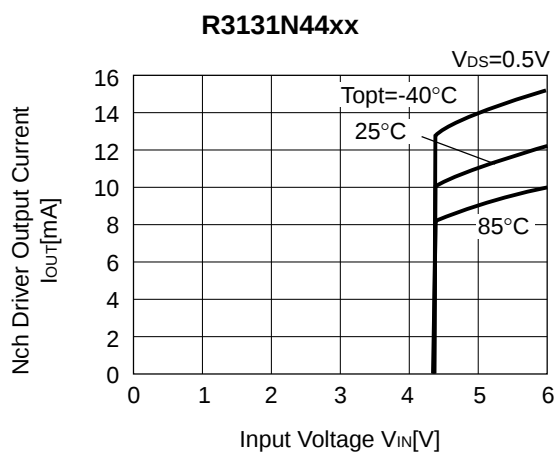
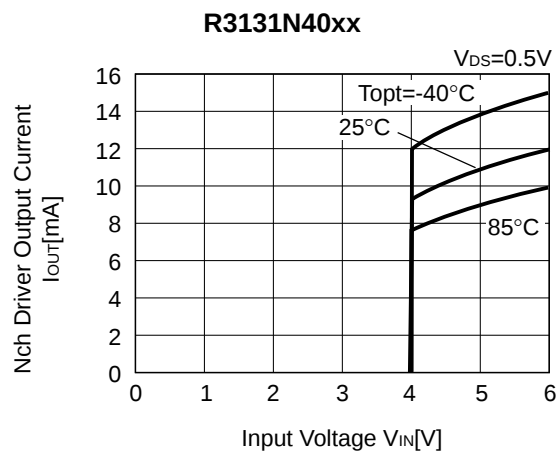
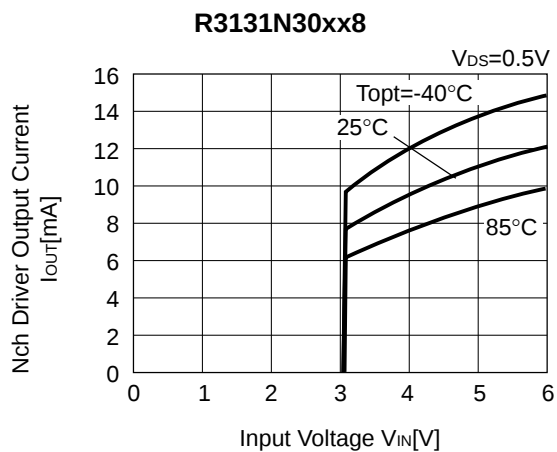
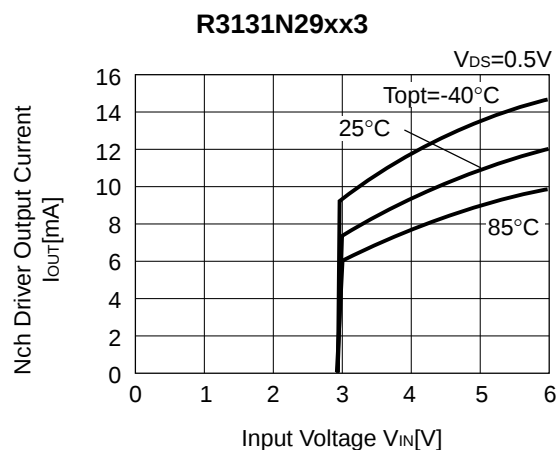
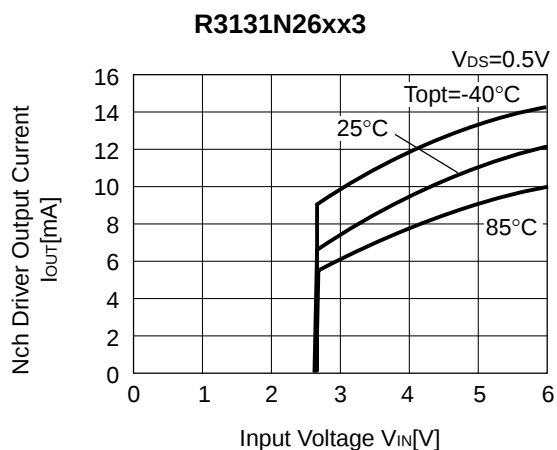
R3130N44xx



R3130N46xx5

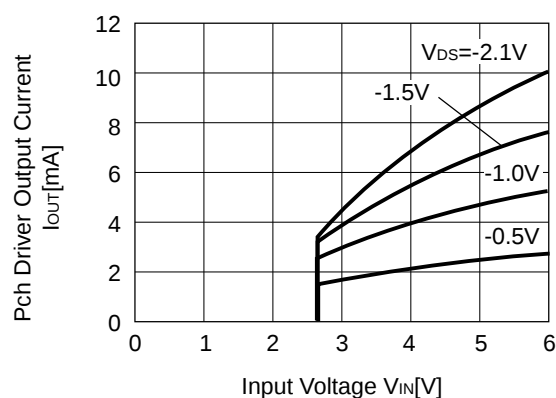


R3130N/R3131N

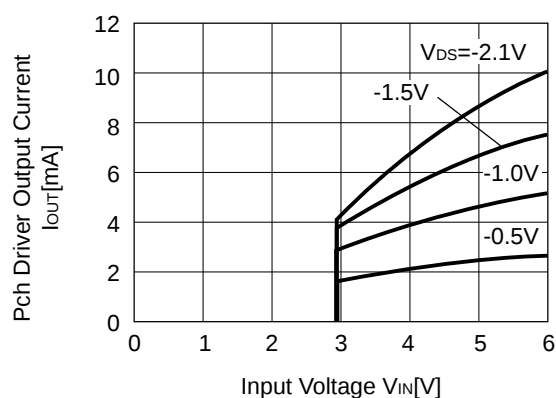


5) Pch Driver Output Current vs. Input Voltage

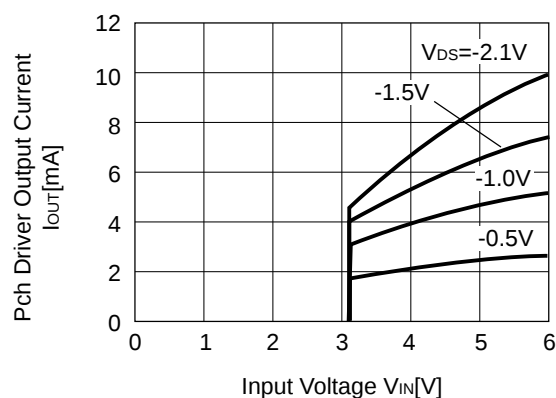
R3130N26xx3



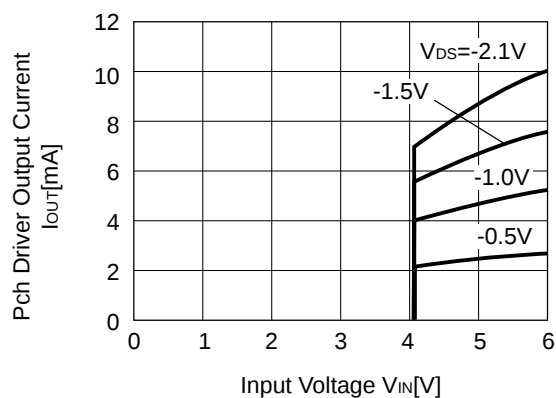
R3130N29xx3



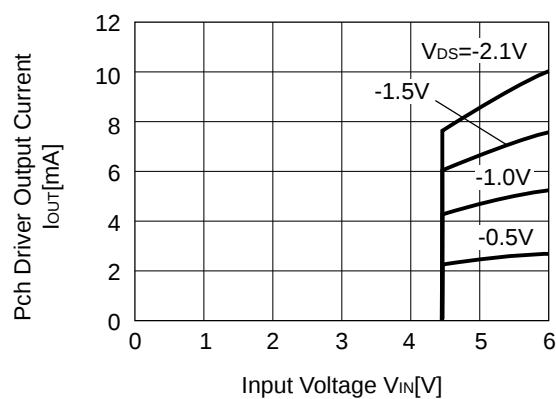
R3130N30xx8



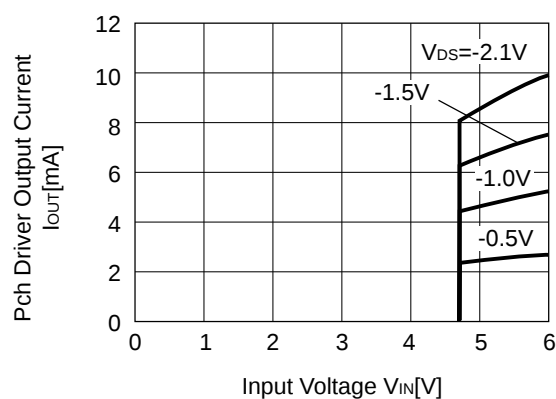
R3130N40xx



R3130N44xx



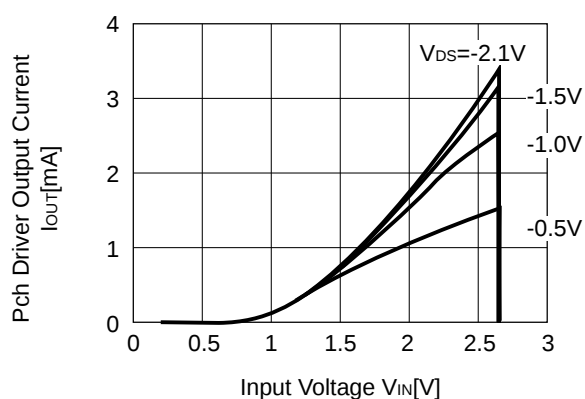
R3130N46xx5



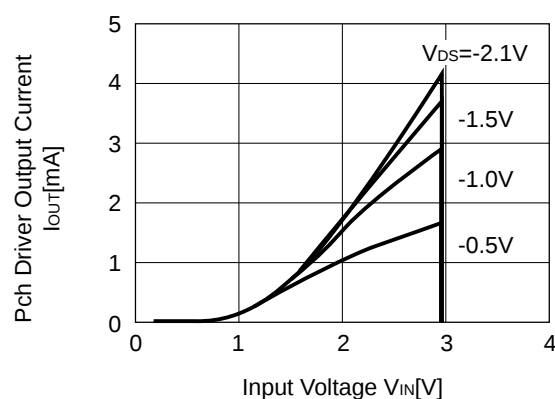
* R3130NxxB/D/H (SOT23-3) are the limited products and R3131N (SOT-23-3) is the discontinued product as of March, 2016.

R3130N/R3131N

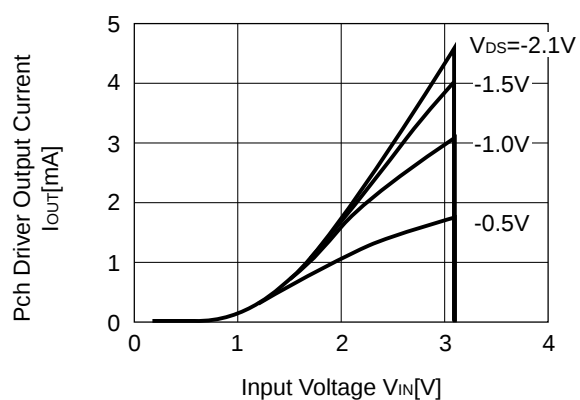
R3131N26xx3



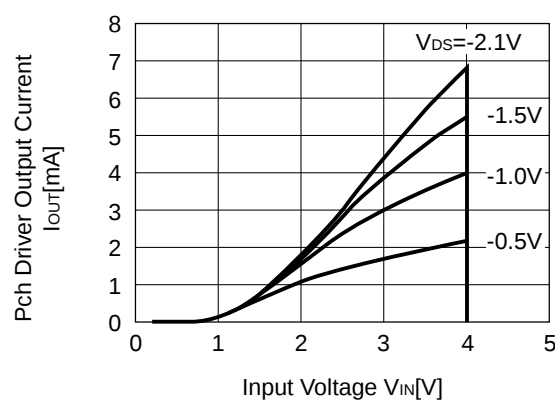
R3131N29xx3



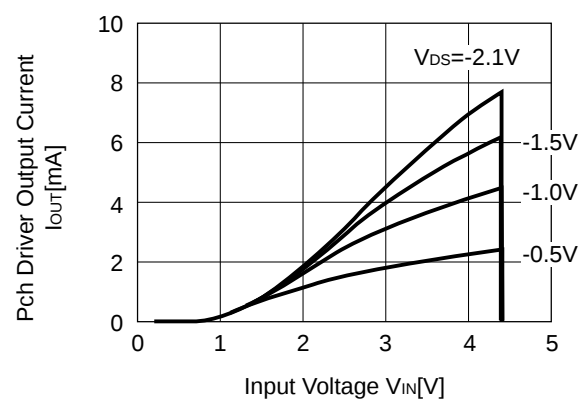
R3131N30xx8



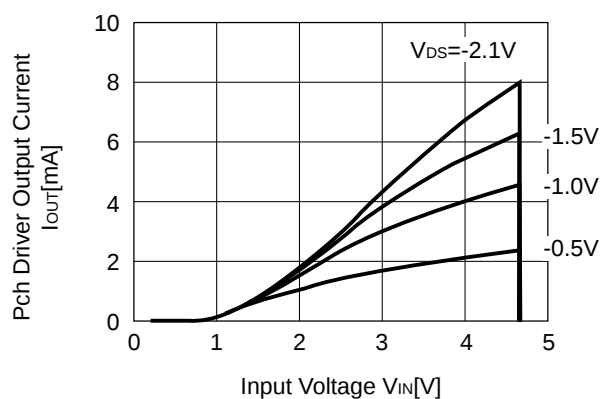
R3131N40xx



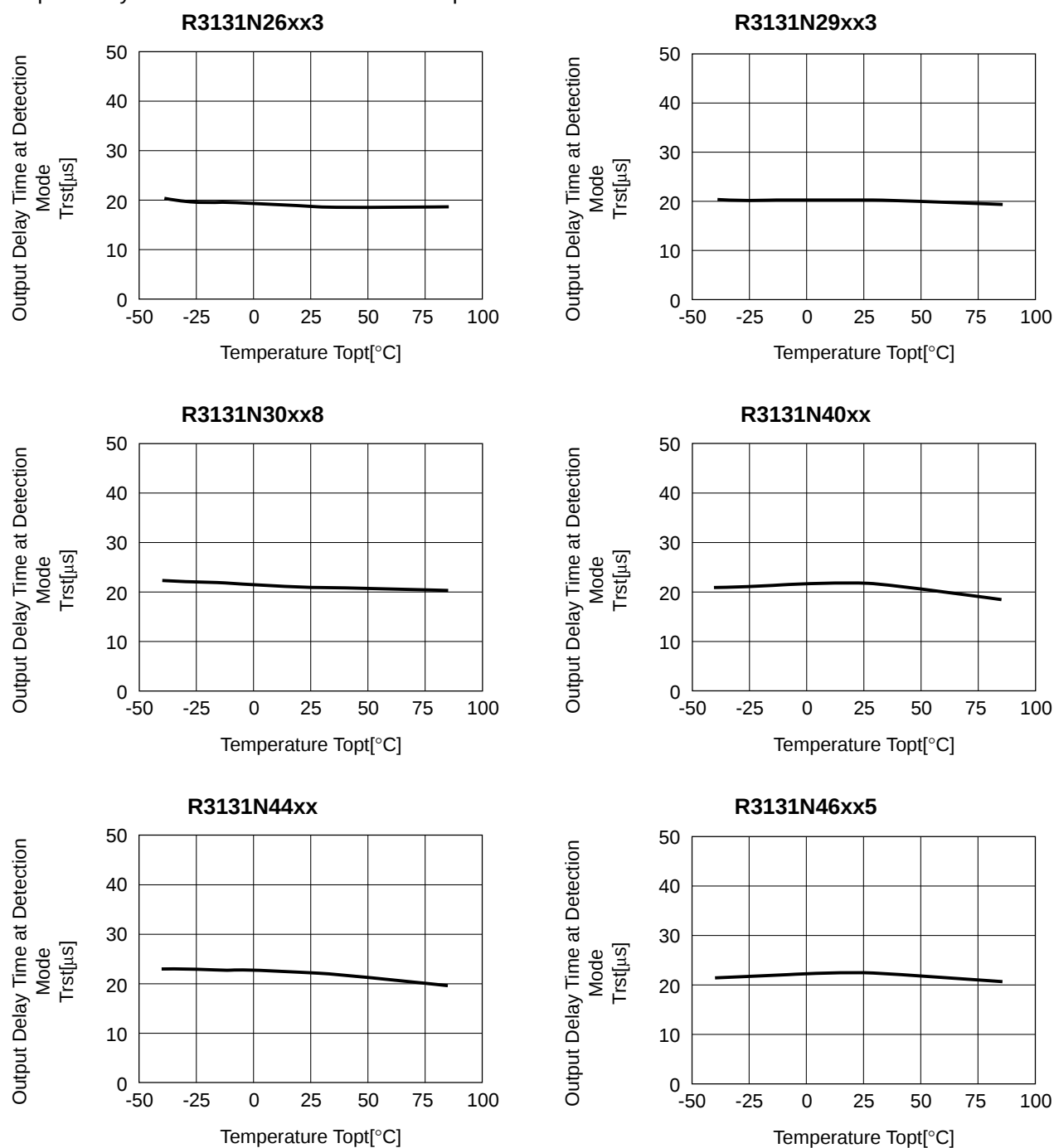
R3131N44xx



R3131N46xx5



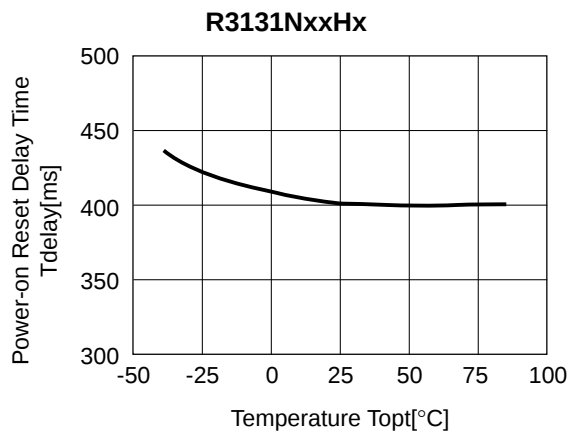
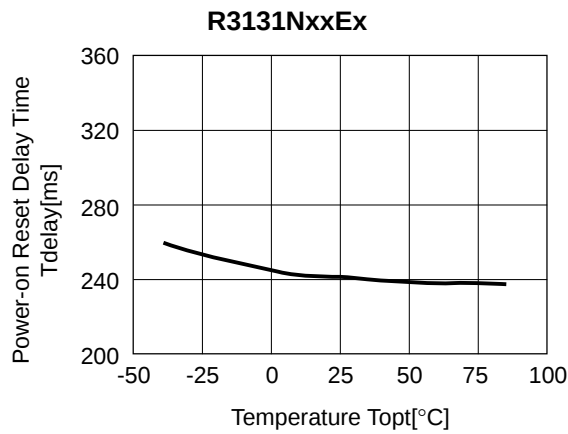
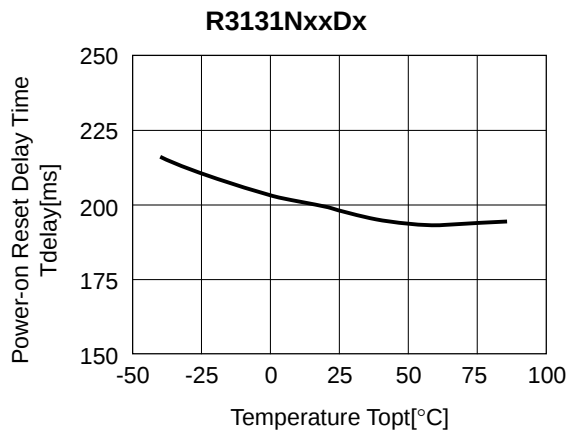
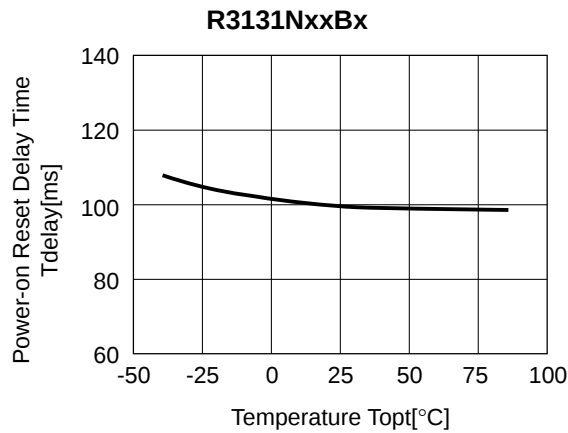
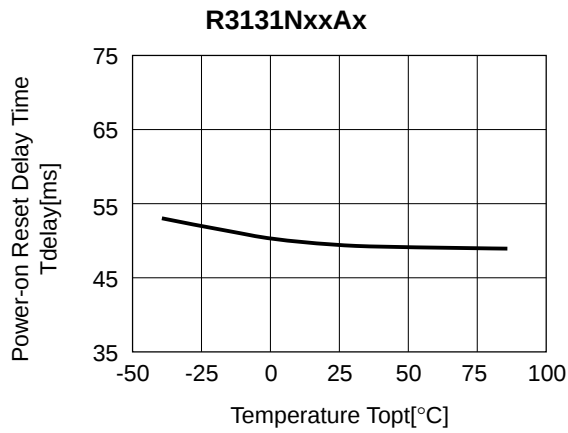
6) Output Delay Time at Detection Mode vs. Temperature



* R3130NxxB/D/H (SOT23-3) are the limited products and R3131N (SOT-23-3) is the discontinued product as of March, 2016.

R3130N/R3131N

7) Power-on Reset Delay Time vs. Temperature



TECHNICAL NOTES

When connecting resistors to the device's input pin

When connecting a resistor (R1) to an input of this device, the input voltage decreases by [Device's Consumption Current] x [Resistance Value] only. And, the cross conduction current^{*1}, which occurs when changing from the detecting state to the release state, is decreased the input voltage by [Cross Conduction Current] x [Resistance Value] only. And then, this device will enter the re-detecting state if the input voltage reduction is larger than the difference between the detector voltage and the released voltage.

When the input resistance value is large and the VDD is gone up at mildly in the vicinity of the released voltage, repeating the above operation may result in the occurrence of output.

As shown in Figure A/B, set R1 to become 100 kΩ or less as a guide, and connect C_{IN} of 0.1 μF and more to between the input pin and GND. Besides, make evaluations including temperature properties under the actual usage condition, with using the evaluation board like this way. As a result, make sure that the cross conduction current has no problem.

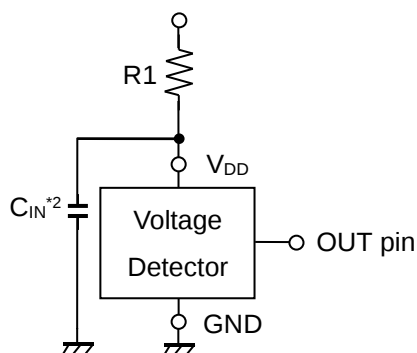


Figure A

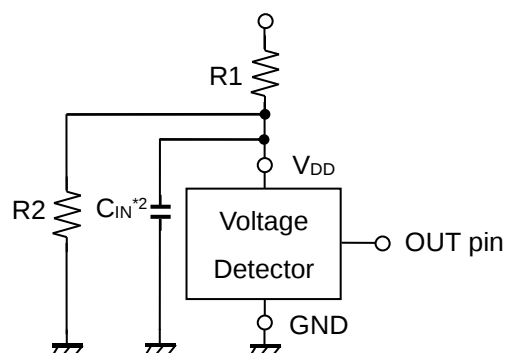


Figure B

^{*1} In the CMOS output type, a charging current for OUT pin is included.

^{*2} Note the bias dependence of capacitors.



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